## **DESCRIPTION**

The AM10P10D is available in TO-252 Package.

BVDSS	RDSON	ID
-100V	150 mΩ	-10A

## **FEATURES**

- -100V, -10A
- RDS(ON) Typ =  $150m\Omega$  @ VGS = -10V
- RDS(ON) Typ =  $170 \text{m}\Omega$  @ VGS = -4.5V
- Advanced Trench Technology
- Excellent RDS(ON) and Low Gate Charge

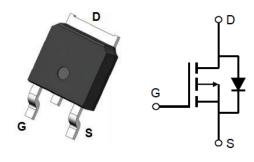
## **APPLICATION**

- Load Switch
- PWM Application
- Power Management

## ORDERING INFORMATION

Package Type	Part Number		
TO-252		AM10P10DVR	
SPQ: 2,500/Reel	D	AMITOPTODVR	
Note	V: Halogen free Package		
Note	R: Tape & Reel		
AiT provides all RoHS products			

### PIN DESCRIPTION



Pin#	Symbol	Function
1	G	Gate
2	D	Drain
3	S	Source

## **ABSOLUTE MAXIMUM RATINGS**

#### T<sub>J</sub> = 25°C unless otherwise specified

V <sub>DS</sub> , Drain-to-Source Voltage		-100V
V <sub>GS</sub> , Gate-to-Source Voltage		±20V
L. Continuous Drain Current	T <sub>C</sub> = 25°C	-10A
I <sub>D</sub> , Continuous Drain Current	T <sub>C</sub> = 100°C	-6A
I <sub>DM</sub> , Pulsed Drain Current (1)		-40A
E <sub>AS</sub> , Single Pulse Avalanche Energy (2)		46mJ
P <sub>D</sub> , Power Dissipation	T <sub>C</sub> = 25°C	34W
Reuc, Thermal Resistance, Junction to Case		3.7°C/W
T <sub>J</sub> , T <sub>STG</sub> , Junction & Storage Temperature Range		-55°C ∼ +150°C

Stresses above may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated in the Electrical Characteristics are not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

- (1) Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
- (2)  $E_{AS}$  comdton Starting T,=25°C,  $V_{DD}$ =-50V,  $V_{G}$ =-10V,  $R_{G}$ =25ohm, L=0.5mH,  $I_{AS}$ =-13.5A

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**MOSFET** -100V -10A P-CHANNEL MOSFET

# **ELECTRICAL CHARACTERISTICS**

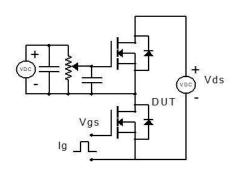
T」=25°C, unless otherwise noted.						
Parameter	Symbol	Conditions	Min	Тур.	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	V <sub>(BV)DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250μA	-100	-	-	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = -100V, V <sub>GS</sub> =0V	-	-	-1	μΑ
Gate-Body Leakage Current	Igss	V <sub>GS</sub> =±20V, V <sub>DS</sub> = 0V	-	-	±100	nA
On Characteristics						
Gate Threshold Voltage	V <sub>GS (th)</sub>	V <sub>GS</sub> =V <sub>DS</sub> , I <sub>D</sub> =-250μA	-1.1	-1.6	-2.2	V
Static Drain Source ON-	_	\/ 40\/ L 54		150	195	
Resistance (3)	R <sub>DS(ON)</sub>	V <sub>GS</sub> =-10V, I <sub>D</sub> = -5A	-			mΩ
Static Drain Source ON-		_		170	224	0
Resistance (3)	R <sub>DS(ON)</sub>	V <sub>GS</sub> =-4.5V, I <sub>D</sub> = -4A		170	221	.21   mΩ
Dynamic Characteristics						
Input Capacitance	Ciss	)/ OF)/ )/ O)/	-	2577	-	pF
Output Capacitance	Coss	- V <sub>DS</sub> = -25V, V <sub>GS</sub> =0V, - f=1MHz	-	66	-	
Reverse Transfer Capacitance	Crss		-	52	-	
Total Gate Charge	Qg	V <sub>GS</sub> =0 to -10V,	-	45	-	nC
Gate Source Charge	Qgs		-	4.5	-	
Gate-Drain Charge	$Q_{gd}$	V <sub>DS</sub> =-50V, I <sub>D</sub> =-10A	-	5.7	-	
Switching Characteristics	•		•	•		•
Turn-On Delay Time	t <sub>d(on)</sub>		-	22	-	
Turn-On Rese Time	tr	V <sub>GS</sub> =-10V, V <sub>DD</sub> =-50V	-	30	-	
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_{GEN}$ =10 $\Omega$ , $I_D$ =-6.5A	-	58	-	ns
Turn-Off Fall Time	t <sub>f</sub>		-	48	-	
Drain-Source Diode Characteristic	cs and Max	Ratings	•	•		•
Maximum Continuous Drain to					40	
Source Diode Forward Current	Is	-	-	-	-10	Α
Maximum Pulsed Drain to Source		-	-	-	-40	А
Diode Forward Current	Ism					
Drain to Source Diode Forward	V	V <sub>GS</sub> =0V, I <sub>S</sub> =-5A	-	-	-1.2	V
Voltage	V <sub>SD</sub>					

<sup>(3)</sup> Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%.

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# TEST CIRCUIT

Fig 1. Gate Charge Test Circuit & Waveform



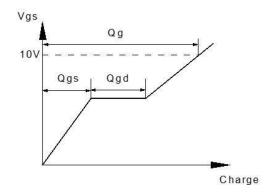
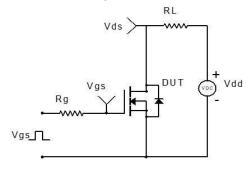


Fig 2. Resistive Switching Test Circuit & Waveform



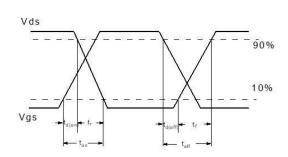
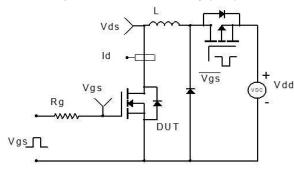


Fig 3. Unclamped Inductive Switching (UIS) Test Circuit & Waveform



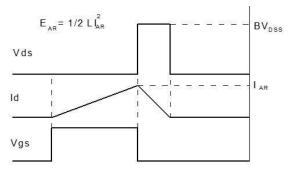
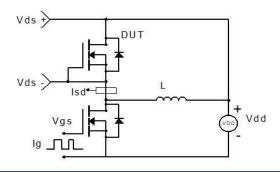
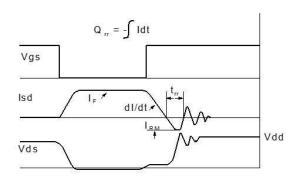


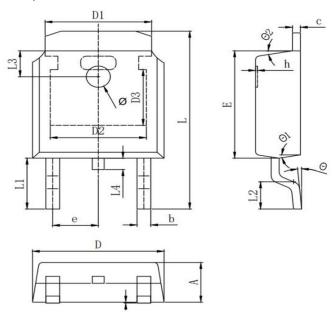
Fig 4. Diode Recovery Test Circuit & Waveform





# **PACKAGE INFORMATION**

Dimension in TO-252 (Unit: mm)



Symph al	Millimeters		
Symbol	Min.	Max.	
Α	2.200	2.400	
A1	0.000	0.127	
b	0.640	0.740	
С	0.460	0.580	
D	6.500	6.700	
D1	5.334 REF.		
D2	4.826 REF.		
D3	3.166 REF.		
Е	6.000	6.200	
е	2.286 TYP.		
h	0.000	0.200	
L	9.900	10.300	
L1	2.888 REF.		
L2	1.400	1.700	
L3	1.600 REF.		
L4	0.600	1.000	
Ф	1.100	1.300	
θ	0° 8°		
θ1	9° TYP.		
θ2	9° TYP.		

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AM10P10D MOSFET -100V -10A P-CHANNEL MOSFET

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